

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

Bare Die

OptiMOS™3 Power MOS Transistor Chip IPC042N03L3

Data Sheet

Rev. 2.5 Final





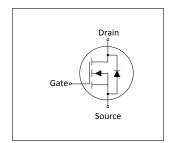
Description 1

- N-channel enhancement mode
- For dynamic characterization refer to the datasheet of IPD040N03LG
- AQL 0.65 for visual inspection according to failure catalogue
- Electrostatic Discharge Sensitive Device according to MIL-STD 883C
- Die bond: soldered or glued
- Backside metallization: NiV systemFrontside metallization: AlCu system



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Parameter	Value	Unit			
V _{(BR)DSS}	30	V			
R _{DS(on)}	4.01)	mΩ			
Die size	2.78 x 1.53	mm ²			
Thickness	175	μm			











Type / Ordering Code	Package	Marking	Related Links
IPC042N03L3	Chip	not defined	-

Electrical Characteristics on Wafer Level

at $T_i = 25$ °C, unless otherwise specified

Table 2

D	Symbol	Values		11	Nata / Tank Caralitian	
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	30	-	-	V	V_{GS} =0 V , I_D =1 mA
Gate threshold voltage	$V_{\rm GS(th)}$	1	-	2.2	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \ \mu {\rm A}$
Zero gate voltage drain current	I _{DSS}	-	-	1	μA	V _{GS} =0 V ,V _{DS} =30 V
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20 V ,V _{DS} =0 V
Drain-source on- resistance	R _{DS(on)}	-	3.7 ²⁾ 2.3 ²⁾	50 ³⁾ 50 ³⁾	mΩ	V _{GS} =4.5 V ,I _D =2.0 A V _{GS} =10 V ,I _D =2.0 A
Reverse diode forward on-voltage	V _{SD}	-	0.83	1.1	V	V _{GS} =0 V , <i>I</i> _F =1A
Avalanche energy, single pulse	E _{AS}	-	-	60	mJ	I_D =50 A, R_{GS} =25 Ω

 $^{^{1)}}$ packaged in a DPAK using Al bond wire (see ref. product) typical bare die $R_{\rm DS(on)};~V_{\rm GS}$ =10 V when used with 4x500µm Al-wedge double-stitch bonding limited by wafer test-equipment



3 Package Outlines

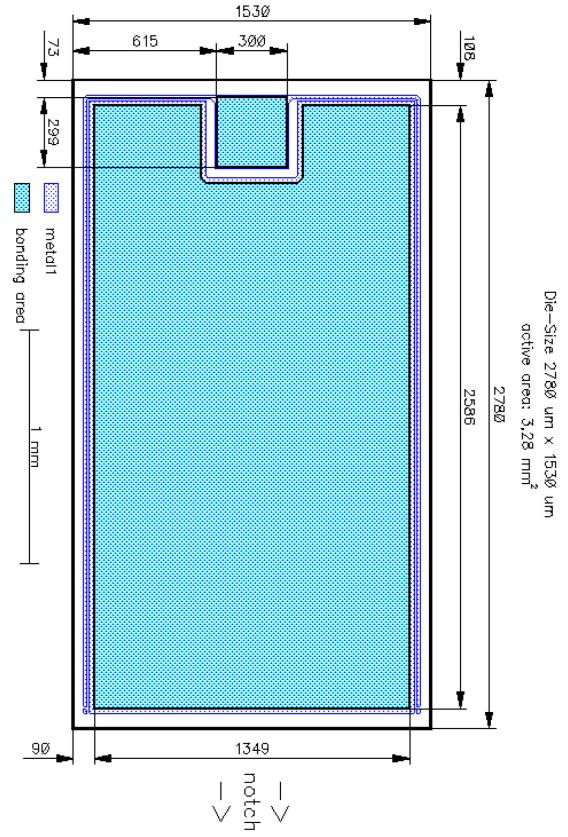


Figure 1 Outline Chip, dimensions in µm



OptiMOS™3 Power MOS Transistor Chip

IPC042N03L3

Revision History

IPC042N03L3

Revision: 2014-07-25, Rev. 2.5

Previous Revision

Revision	Date	Subjects (major changes since last revision)		
2.5	2014-07-25	Release of Final Version		

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